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FQP3P50 P-Channel QFET MOSFET -500 V, -2.7 A, 4.9 Ω

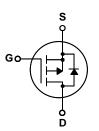
Description

This P-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- -2.7 A, -500 V, $\rm R_{DS(on)}$ = 4.9 Ω (Max) @V_{GS} = 10 V, $\rm I_{D}$ = -1.35 A
- Low Gate Charge (Typ. 18 nC)
- Low Crss (Typ. 9.5 pF)
- 100% Avalanche Tested





Absolute Maximum Ratings T_c = 25°C unless otherwise noted

Symbol	Parameter		FQP3P50	Unit
V _{DSS}	Drain-Source Voltage		-500	V
I _D	Drain Current - Continuous (T _C = 25°	°C)	-2.7	А
	- Continuous (T _C = 100°C)		-1.71	А
I _{DM}	Drain Current - Pulsed	(Note 1)	-10.8	А
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	250	mJ
I _{AR}	Avalanche Current	(Note 1)	-2.7	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	8.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-4.5	V/ns
P _D	Power Dissipation ($T_C = 25^{\circ}C$)		85	W
	- Derate above 25°C		0.68	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum lead temperature for soldering purposes,1/8" from case for 5 seconds		300	°C
۰L			300	

Thermal Characteristics

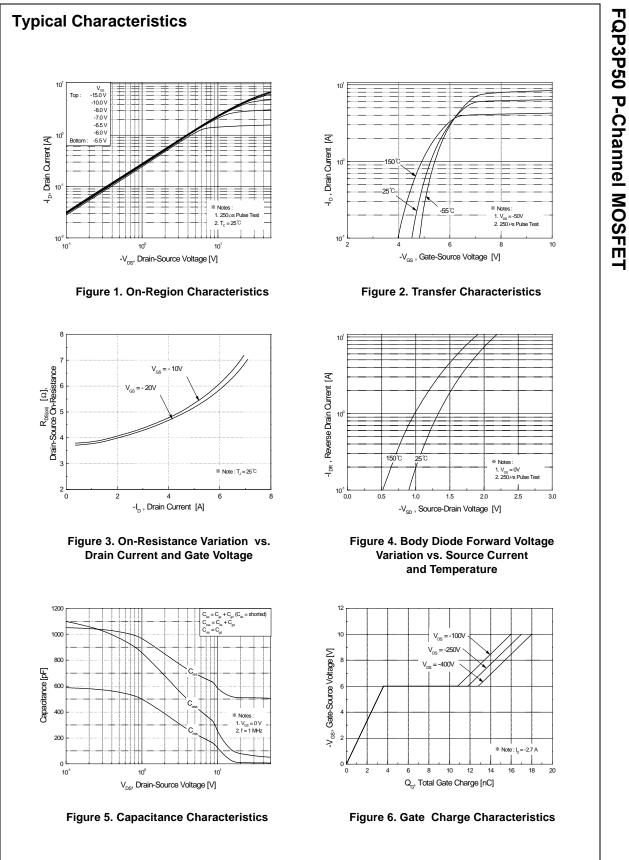
Symbol	Parameter	Тур	Max	Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case		1.47	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink	0.5		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

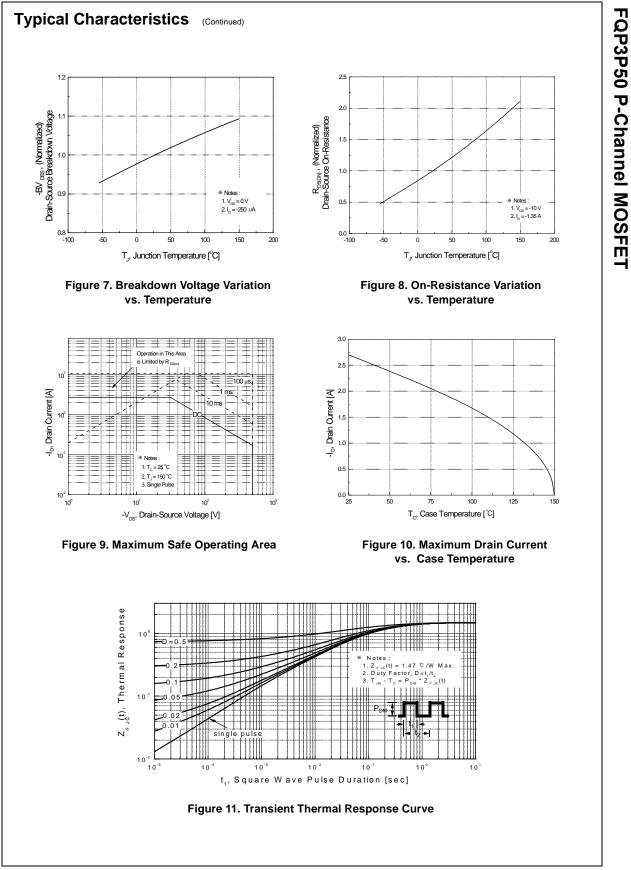
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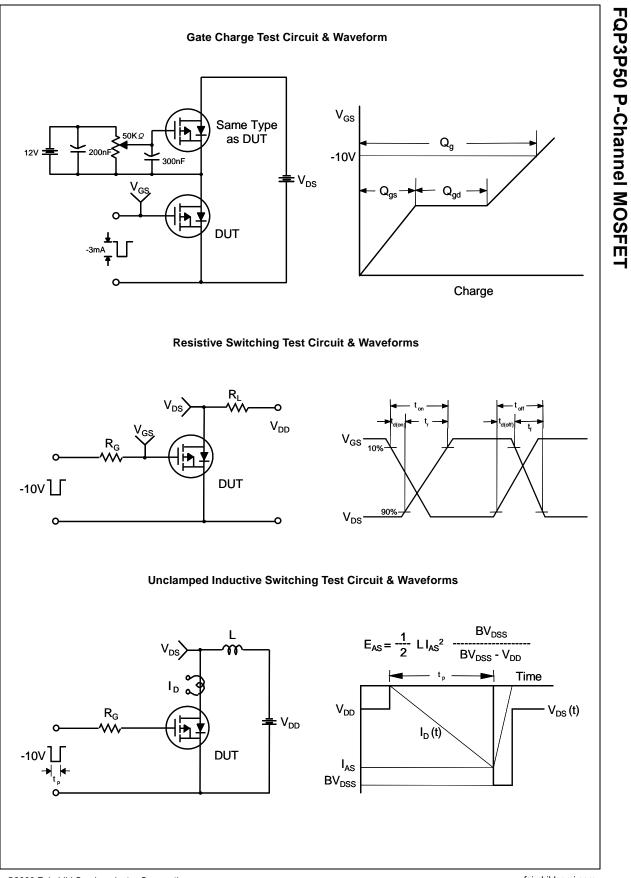
	Parameter	Test Conditions	Min	Тур	Max	Unit
Off Cha	racteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = -250 μA	-500			V
ΔBV _{DSS}	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu$ A, Referenced to 25°C		0.42		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -500 V, V _{GS} = 0 V			-1	μA
		V _{DS} = -400 V, T _C = 125°C			-10	μA
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
	racteristics				50	.,
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250 \mu\text{A}$	-3.0		-5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V_{GS} = -10 V, I _D = -1.35 A		3.9	4.9	Ω
9 _{FS}	Forward Transconductance	V _{DS} = -50 V, I _D = -1.35 A (Note 4)		2.35		S
		1	1		1	
	c Characteristics	Γ			1	
C _{iss}	Input Capacitance	$V_{DS} = -25 V, V_{GS} = 0 V,$		510	660	pF
C _{oss}	Output Capacitance	f = 1.0 MHz		70	90	pF
C _{rss}	Reverse Transfer Capacitance			9.5	12	pF
Switchi t _{d(on)}	ng Characteristics			12	35	ns
t _r	Turn-On Rise Time	$V_{DD} = -250 \text{ V}, \text{ I}_{D} = -2.7 \text{ A},$		56	120	ns
t _{d(off)}	Turn-Off Delay Time	$R_{G} = 25 \Omega$		35	80	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		45	100	ns
Q _g	Total Gate Charge	$V_{-} = 400 V_{-} = 2.7 A_{-}$		18	23	nC
∽g Q _{gs}	Gate-Source Charge	V _{DS} = -400 V, I _D = -2.7 A, V _{GS} = -10 V		3.6		nC
Q _{gd}	Gate-Drain Charge	(Note 4, 5)		9.2		nC
94	0					
Drain-S	ource Diode Characteristics ar	nd Maximum Ratings			1	
I _S	Maximum Continuous Drain-Source Dic	ce Diode Forward Current			-2.7	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F				-10.8	A
V _{SD}	Drain-Source Diode Forward Voltage				-5.0	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 V, I_S = -2.7 A,$		270		ns
Q _{rr}	Reverse Recovery Charge	$dI_{F} / dt = 100 \text{ A}/\mu \text{s}$ (Note 4)		1.5		μC

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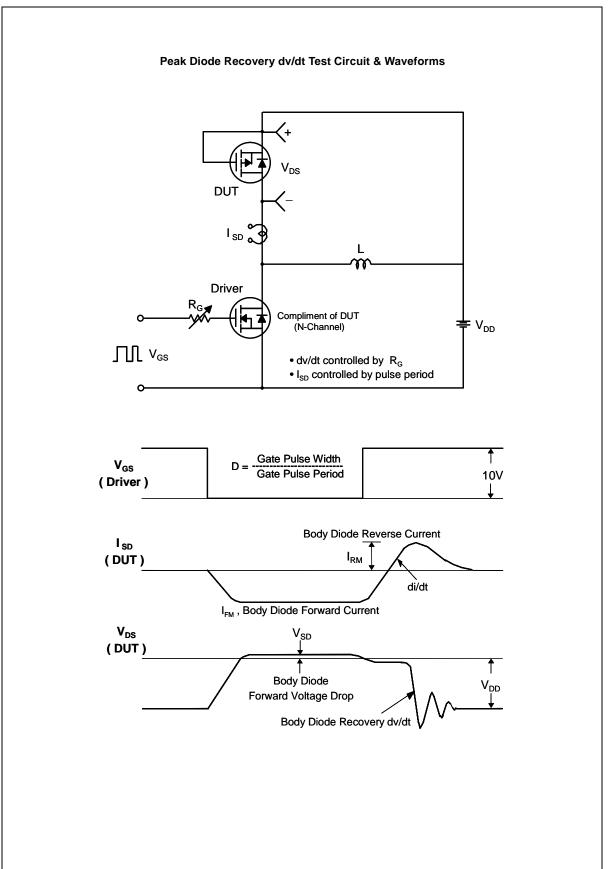




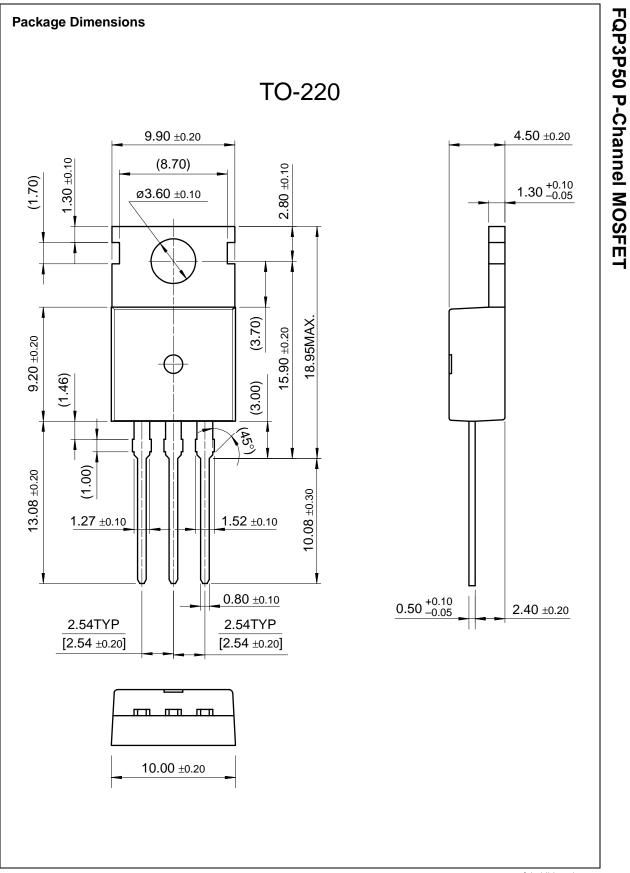
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